

Search Notes

Application/Control No.

09/776,669

Examiner

Stefano Karmis

Applicant(s)/Patent under
Reexamination

LEE, YUAN-CHIEH

Art Unit

3624

SEARCHED

Class	Subclass	Date	Examiner
705	35	9/19/05	AL
705	37	9/19/05	AL
705	39	9/19/05	AL
705	40	9/19/05	AL
705	42	9/19/05	AL
705	44	9/19/05	AL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST KEYWORDS (ATTACHED)	9/19/05	AL